

No. I19Z60566-SEM03

For

Shenzhen Tinno Mobile Technology Corp.

Smart Phone

Model Name: U304AA

With

Hardware Version: V1.0

Software Version: U304AAV01.18.11

FCC ID: XD6U304AA

Results Summary: T Category = T4

Issued Date: 2019-5-7

NVLAP LAB CODE 600118-0

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REPORT HISTORY

Report Number	Revision	Issue Date	Description
I19Z60566-SEM03	Rev.0	2019-5-7	Initial creation of test report



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1 Test Laboratory

1.1 Testing Location

Company Name:	CTTL(Shouxiang)
Address:	No. 51 Shouxiang Science Building, Xueyuan Road, Haidian District,
	Beijing, P. R. China100191

1.2 Testing Environment

Temperature:	18°C~25°C,
Relative humidity:	30%~ 70%
Ground system resistance:	< 0.5 Ω
	· · · · · · · · · · · · · · · · · · ·

Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.

1.3 Project Data

Project Leader:	Qi Dianyuan
Test Engineer:	Lin Hao
Testing Start Date:	April 29, 2019
Testing End Date:	May 3, 2019

1.4 Signature

Lin Xiaojun (Prepared this test report)



Qi Dianyuan (Reviewed this test report)

Lu Bingsong Deputy Director of the laboratory (Approved this test report)



2 Client Information

2.1 Applicant Information

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2.2 Manufacturer Information

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Contact:	Jingwen.Guo	
Email:	jingwen.guo@tinno.com	
Telephone:	0755-86095550	
Fax:	/	



3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1 About EUT

Description:	Smart Phone
Model name:	U304AA
Operating mode(s):	GSM 850/900/1800/1900 WCDMA850/1700/1900
	LTE B2/4/5/12/14/30, BT, WiFi

3.2 Internal Identification of EUT used during the test

EUT ID*	IMEI	HW Version	SW Version	
EUT1	863382040008870	V1.0	U304AAV01.18.11	
EUT2	863382040009357	V1.0	U304AAV01.18.11	
EUT3	863382040009316	V1.0	U304AAV01.18.11	

*EUT ID: is used to identify the test sample in the lab internally.

Note: It is performed to test T-coil with the EUT1&2 and conducted power with the EUT3.

3.3 Internal Identification of AE used during the test

AE ID*	Description	Model	SN	Manufacturer
AE1	Battery	LT25H426271B	0	Shenzhen BYD Lithium Battery Company Limited

*AE ID: is used to identify the test sample in the lab internally.

3.4 Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Туре	C63.19/tested	Simultaneous Transmissions	οττ
GSM	850	VO	Yes		NA
0.51	1900	~~	165		
GPRS/EDGE	850	DT	NA	BT, WLAN	
	1900				
WCDMA (UMTS)	850	VO	Yes	BT, WLAN	NA
	1700				
	1900			2.,	
	HSPA	DT	NA		
LTE	Band 2/4/5/12/14/30	V/D	Yes	BT, WLAN	NA
BT	2450	DT	NA	GSM, WCDMA,LTE	NA
WLAN	2450	V/D	NA	GSM, WCDMA,LTE	NA

VO: Voice CMRS/PSTN Service Only V/D: Voice CMRS/PSTN and Data Service DT: Digital Transport

* HAC Rating was not based on concurrent voice and data modes, Non current mode was found to represent worst case rating for both M and T rating

Note1 = No Associated T-Coil measurement has been made in accordance with 285076 D02 T-Coil testing for CMRS IP



4 Reference Documents

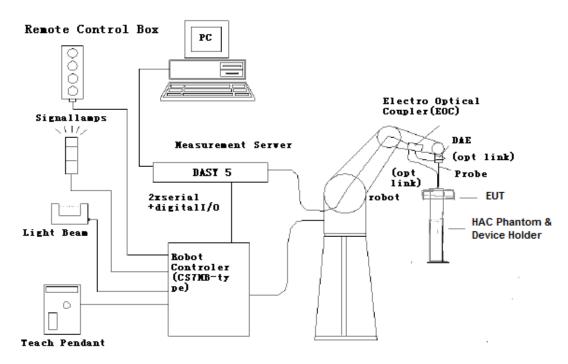
Reference	Title	Version
ANSI C63.19-2011	American National Standard for Methods of Measurement	
	of Compatibility between Wireless Communication Devices	
	and Hearing Aids	

The following document listed in this section is referred for testing.

5 OPERATIONAL CONDITIONS DURING TEST

5.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core21.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE)circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.



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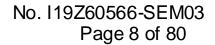




Figure 5.1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



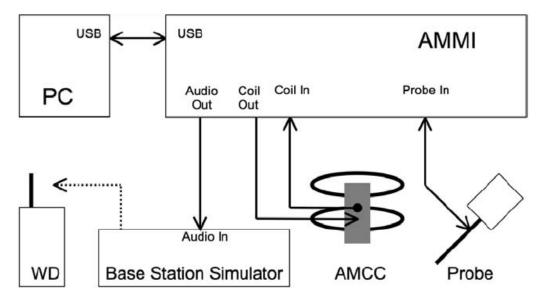


Figure 5.2 T-Coil setup with HAC Test Arch and AMCC



5.2 AM1D probe

The AM1D probe is an active probe with a single sensor. It is fully RF-shielded and has a rounded tip 6mm in diameter incorporating a pickup coil with its center offset 3mm from the tip and the sides. The symmetric signal preamplifier in the probe is fed via the shielded symmetric output cable from the AMMI with a 48V "phantom" voltage supply. The 7-pin connector on the back in the axis of the probe does not carry any signals. It is mounted to the DAE for the correct orientation of the sensor. If the probe axis is tilted 54.7 degree from the vertical, the sensor is approximately vertical when the signal connector is at the underside of the probe (cable hanging downwards). Specification:

Frequency range0.1~20kHz (RF sensitivity < -100dB, fully RF shielded)				
Sensitivity <-50dB A/m @ 1kHz				
Pre-amplifier	40dB, symmetric			
Dimensions	Tip diameter/length: 6/290mm, sensor according to ANSI-C63.19			

5.3 AMCC

The Audio Magnetic Calibration coil is a Helmholtz Coil designed for calibration of the AM1D probe. The two horizontal coils generate a homogeneous magnetic field in the z direction. The DC input resistance is adjusted by a series resistor to approximately 500hm, and a shunt resistor of 100hm permits monitoring the current with a scale of 1:10

Port description:

Signal	Connector	Resistance
Coil In	BNC	Typically 50Ohm
Coil Monitor	BNO	100hm±1% (100mV corresponding to 1 A/m)
Specification:		

Dimensions	370 x 370 x 196 mm, according to ANSI-C63.19

5.4 AMMI



Figure 5.3 AMMI front panel

The Audio Magnetic Measuring Instrument (AMMI) is a desktop 19-inch unit containing a sampling unit, a waveform generator for test and calibration signals, and a USB interface. Specification:

Sampling rate	48 kHz / 24 bit
Dynamic range	85 dB
Test signal generation	User selectable and predefined (vis PC)
Calibration	Auto-calibration / full system calibration using AMCC with monitor output
Dimensions	482 x 65 x 270 mm



5.5 Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field < \pm 0.5 dB.



Figure 5.4 HAC Phantom & Device Holder

5.6 Robotic System Specifications

Specifications Positioner: Stäubli Unimation Corp. Robot Model: RX160L Repeatability: ±0.02 mm No. of Axis: 6 Data Acquisition Electronic (DAE) System Cell Controller Processor:Intel Core2 Clock Speed: 1.86GHz Operating System: Windows XP Data Converter Features:Signal Amplifier, multiplexer, A/D converter, and control logic Software: DASY5 software Connecting Lines:Optical downlink for data and status info. Optical uplink for commands and clock



5.7 T-Coil measurement points and reference plane

Figure 6.5 illustrates the standard probe orientations. Position 1 is the perpendicular orientation of the probe coil; orientation 2 is the transverse orientations. The space between the measurement positions is not fixed. It is recommended that a scan of the WD be done for each probe coil orientation and that the maximum level recorded be used as the reading for that orientation of the probe coil.

1) The reference plane is the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver area of the phone and is defined by the points of the receiver-end of the WD handset, which, in normal handset use, rest against the ear.

2) The measurement plane is parallel to, and 10 mm in front of, the reference plane.

3) The reference axis is normal to the reference plane and passes through the center of the receiver speaker section (or the center of the hole array); or may be centered on a secondary inductive source. The actual location of the measurement point shall be noted in the test report as the measurement reference point.

4) The measurement points may be located where the axial and radial field intensity measurements are optimum with regard to the requirements. However, the measurement points should be near the acoustic output of the WD and shall be located in the same half of the phone as the WD receiver. In a WD handset with a centered receiver and a circularly symmetrical magnetic field, the measurement axis and the reference axis would coincide.

5) The relative spacing of each measurement orientation is not fixed. The axial and two radial orientations should be chosen to select the optimal position.

6) The measurement point for the axial position is located 10 mm from the reference plane on the measurement axis. The actual location of the measurement point shall be noted in test reports and designated as the measurement reference point.

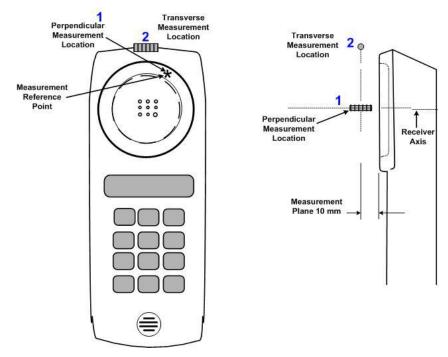


Figure 5.5 Axis and planes for WD audio frequency magnetic field measurements



6 T-Coil TEST PROCEDUERES

The following illustrate a typical test scan over a wireless communications device :

1) Geometry and signal check: system probe alignment, proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the test Arch.

2) Set the reference drive level of signal voice defined in C63.19 per 7.4.2.1.

3) The ambient and test system background noise (dB A/m) was measured as well as ABM2 over the full measurement. The maximum noise level must be at least 10dB below the limit.

4) The DUT was positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.

5) The DUT operation for maximum rated RF output power was configured and connected by using of coaxial cable connection to the base station simulator at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The DUT audio output was positioned tangent (as physically possible) to the measurement plane.

6) The DUT's RF emission field was eliminated from T-coil results by using a well RF-shielding of the probe, AM1D, and by using of coaxial cable connection to a Base Station Simulator. One test channel was pre-measurement to avoid this possibility.

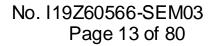
7) Determined the optimal measurement locations for the DUT by following the three steps, coarse resolution scan, fine resolution scans, and point measurement, as described in C63.19 per 7.4.4.2. At each measurement locations, samples in the measurement window duration were evaluated to get ABM1 and the signal spectrum. The noise measurement was performed after the scan with the signal, the same happened, just with the voice signal switched off. The ABM2 was calculated from this second scan.

8) All results resulting from a measurement point in a T-Coil job were calculated from the signal samples during this window interval. ABM values were averaged over the sequence of there samples.

9) At an optimal point measurement, the SNR (ABM1/ABM2) was calculated for perpendicular and transverse orientation, and the frequency response was measured for perpendicular.

10) Corrected for the frequency response after the DUT measurement since the DASY5 system had known the spectrum of the input signal by using a reference job.

11) In SEMCAD postprocessing, the spectral points are in addition scaled with the high-pass (half-band) and the A-weighting, bandwidth compensated factor (BWC) and those results are final as shown in this report.





7 T-Coil PERFORMANCE REQUIREMENTS

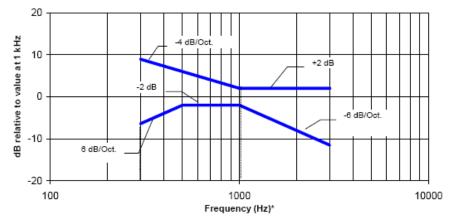
In order to be rated for T-Coil use, a WD shall meet the requirements for signal level and signal quality contained in this part.

7.1 T-Coil coupling field intensity

When measured as specified in ANSI C63.19, the T-Coil signal shall be ≥ -18 dB (A/m) at 1 kHz, ina1/3 octave band filter for all orientations.

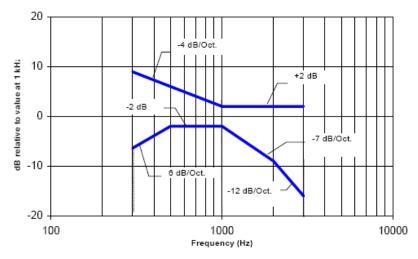
7.2 Frequency response

The frequency response of the axial component of the magnetic field, measured in 1/3 octave bands, shall follow the response curve specified in this sub-clause, over the frequency range 300 Hz to 3000 Hz. Figure 7.1 and Figure 7.2 provide the boundaries for the specified frequency. These response curves are for true field strength measurements of the T-Coil signal. Thus the 6 dB/octave probe response has been corrected from the raw readings.



NOTE—Frequency response is between 300 Hz and 3000 Hz.

Figure 7.1—Magnetic field frequency response for WDs with a field ≤ –15 dB (A/m) at 1 kHz



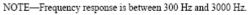


Figure 7.2—Magnetic field frequency response for WDs with a fieldthat exceeds –15 dB(A/m) at 1 kHz

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7.3 Signal quality

This part provides the signal quality requirement for the intended T-Coil signal from a WD. Only the RF immunity of the hearing aid is measured in T-Coil mode. It is assumed that a hearing aid can have noimmunity to an interference signal in the audio band, which is the intended reception band for this mode. So, the only criteria that can be measured is the RF immunity in T-Coil mode. This is measured using the same procedure as for the audio coupling mode and at the same levels. The worst signal quality of the three T-Coil signal measurements shall be used to determine the T-Coil mode category per Table 1

Category	Telephone parameters
	WD signal quality
	[(signal + noise) – to – noise ratio in decibels]
Category T1	0 dB to 10 dB
Category T2	10 dB to 20 dB
Category T3	20 dB to 30 dB
Category T4	> 30 dB

Table 1:T-Coil signal quality categories



8 CMRS Voice DUT CONFIGURATION

8.1 GSM Codec Investigation

The middle channel of each frequency band is used for T-coil testing according ANSI C63.19-2011. Choose worst case from radio configuration investigation. After investigation was performed to determine the audio codec configuration to be used for testing, the following tests results which the worst case codec would be remarked to be used for the testing for the DUT.

Codec Setting	FR VR	HR V1	EFR	Orientation	Band	Channel
ABM1 (dBA/m)	6.53	6.29	7.09			
Frequency Response	PASS	PASS	PASS	Z(axial)	GSM1900	661
SNR (dB)	<mark>44.29</mark>	45.50	45.06			

Table 8-1	GSM	CMRS	Codec	Investigation
	GOW	CININO	COUEC	Investigation

8.2 UMTS Codec Investigation

The middle channel of each frequency band is used for T-coil testing according ANSI C63.19-2011. Choose worst case from radio configuration investigation. After investigation was performed to determine the audio codec configuration to be used for testing, the following tests results which the worst case codec would be remarked to be used for the testing for the DUT.

Codeo Setting	AMR	AMR	AMR	Orientation	Dand	Channal
Codec Setting	12.2kbps	7.95kbps	4.75kbps	Orientation	Band	Channel
ABM1 (dBA/m)	2.78	1.70	2.69			
Frequency Response	PASS	PASS	PASS	Z(axial)	WCDMA 1900	9400
SNR (dB)	45.37	<mark>44.65</mark>	45.96		1300	

Table 8-2 WCDM A/UMTS CMRS Codec Investigation



9 VOLTE TEST SYSTEM SETUP AND DUT CONFIGURATION

9.1 Test System Setup for VoLTE over IMS T-coil Testing

The general test setup used for VoLTE over IMS is shown below. The callbox used when performing VoLTE over IMS T-coil measurements is a CMW500. The Data Application Unit (DAU) of the CMW500 was used to simulate the IP Multimedia Subsystem (IMS) server.

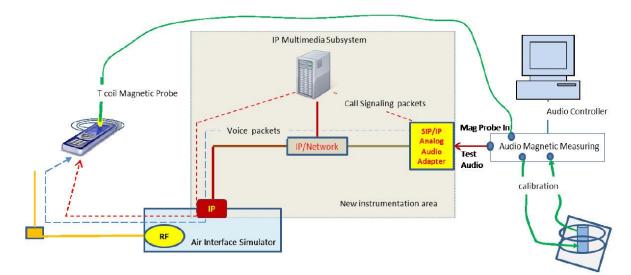


Figure 9.1 Test Setup for VoLTE over IMS T-coil Measurements

9.2 Codec Configuration

An investigation was performed to determine the audio codec configuration to be used for testing. The NB AMR 4.75kbps setting was used for the audio codec on the CMW500 for VoLTE over IMS T-coil testing. See below table for comparisons between different codecs and codec data rates:

Codeo Setting	WBAMR	WBAMR	NB AMR	NB AMR	Orientation	Band/BW	Channel
Codec Setting	23.85kbps	6.60kbps	12.2kbps	4.75kbps	Orientation	Danu/DVV	Channel
ABM1 (dBA/m)	5.80	5.98	4.98	<mark>5.86</mark>		l) B2/20M	18900
Frequency Response	PASS	PASS	PASS	PASS	Z(axial)		
SNR (dB)	47.57	47.25	47.42	<mark>46.56</mark>]		

```
Table 9-1 AMR Codec Investigation – VoLTE over IMS
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Table 9-2 EVS Codec Investigation – VoLTE over IMS

Codec Setting	EVS Primary SWB 13.2kbps	EVS Primary SWB 9.6kbps	EVS Primary WB 13.2kbps	EVS Primary WB 5.9kbps	EVS Primary NB 13.2kbps	EVS Primary NB 5.9kbps	Orientation	Band /BW	Channel
ABM1 (dBA/m)	6.22	6.94	6.16	5.84	6.08	6.44			
Frequency Response	PASS	PASS	PASS	PASS	PASS	PASS	Z(axial)	B2/20M	18900
SNR (dB)	47.35	47.45	47.59	48.11	47.66	47.43			

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9.3 Radio Configuration

An investigation was performed to determine the modulation and RB configuration to be used for testing. 16QAM, 1RB, 50RB offset was used for the testing as the worst-case configuration for the handset. See below table for comparisons between different radio configurations:

Frequency	Channel	Bandwidth				ABM1	SNR
[MHz]	Channel	[MHz]	Modulation	RB Size	RB Offset	[dB(A/m)]	[dB]
1880	18900	20	QPSK	1	0	5.86	46.56
1880	18900	20	QPSK	1	50	5.15	46.66
1880	18900	20	QPSK	1	99	5.38	47.69
1880	18900	20	QPSK	50	0	6.01	47.93
1880	18900	20	QPSK	50	25	6.22	47.78
1880	18900	20	QPSK	50	50	6.23	49.51
1880	18900	20	QPSK	100	0	7.60	50.75
1880	18900	20	16QAM	1	0	5.20	44.79
1880	18900	20	16QAM	1	50	5.32	<mark>43.81</mark>
1880	18900	20	16QAM	1	99	5.65	44.49
1880	18900	20	16QAM	50	0	7.00	48.17
1880	18900	20	16QAM	50	25	7.28	48.10
1880	18900	20	16QAM	50	50	7.33	47.79
1880	18900	20	16QAM	100	0	7.12	48.58
1880	18900	20	64QAM	1	0	7.25	46.55
1880	18900	20	64QAM	1	50	6.73	47.01
1880	18900	20	64QAM	1	99	7.06	46.72
1880	18900	20	64QAM	50	0	7.28	45.89
1880	18900	20	64QAM	50	25	6.89	47.06
1880	18900	20	64QAM	50	50	7.17	46.37
1880	18900	20	64QAM	100	0	7.63	46.58



10 HAC T-Coil TEST DATA SUMMARY

10.1 Test Results for 2/3G

Table 10-1 Test results for 2/3G								
Probe Position	Band	Ch.	Measurement Position	ABM1	SNR	т		
FIDE FUSILION	Danu	Cn.	POSITION	(dB	(dB)	category		
			(x mm, y mm)	A/m)	()	outo gory		
	GSM 850	190	-4.6,12.9	-3.63	38.24	T4		
	GSM 1900	661	-4.2,14.6	-2.97	39.62	T4		
transverse	WCDM A850	4182	-0.4,-4.6	-3.87	42.48	T4		
	WCDM A1900	9400	-3.7,-4.6	-5.26	40.91	T4		
	WCDM A1700	1412	-2.9,-4.6	-4.94	40.95	T4		
	GSM 850	190	2.5,4.6	6.57	42.23	T4		
	GSM 1900	661	0.8,3.7	6.53	44.29	T4		
perpendicular	WCDM A850	4182	-3.3,3.7	4.47	46.08	T4		
	WCDM A1900	9400	-3.3,7.5	1.70	44.65	T4		
	WCDMA1700	1412	-1.2,8.3	4.02	44.93	T4		

Table 10-1 Test results for 2/3G

Note:

- 1. Bluetooth and WiFi function is turn off and microphone is muted.
- 2. Signal strength measurement scan plots are presented in Annex B.
- 3. The volume is adjusted to maximum level during T-Coil testing.



10.2 Test Results for LTE

Table 10-2 Test results for LTE

Probe				Measurement	ABM1	SND	т			
	Band	Ch.	Bandwidth	Position	(dB	SNR				
Position				(x mm, y mm)	A/m)	(dB)	category			
			1.4M	-4.5,-0.5	-4.47	45.84	T4			
			3M	-4.5,-0.5	-4.80	44.34	T4			
	LTE B2	18900	5M	-4.5,-0.5	-4.46	44.86	T4			
		10900	10M	-4.5,-0.5	-4.37	44.74	T4			
			15M	-1.5,-0.5	-1.74	42.96	T4			
			20M	-2.5,-0.5	-2.24	42.62	T4			
			1.4M	-4.5,-0.5	-4.36	44.47	T4			
			3M	-4,-0.5	-4.03	43.30	T4			
	LTE B4	20175	5M	-4, -1	-3.74	42.21	T4			
		20175	10M	-4, -1	-3.74	41.62	T4			
			15M	-4.5, -1	-3.96	41.50	T4			
Transverse			20M	-4.5, -1	-3.99	41.04	T4			
Inditsverse			1.4M	-2,-0.5	-2.42	45.69	T4			
	LTE B5	20525	ЗM	-2,0	-2.68	46.09	T4			
	LIE DO	20525	5M	-3.5,0	-3.37	46.67	T4			
			10M	-3.5,-0.5	-3.66	45.39	T4			
	LTE B12		1.4M	-4.5, -1	-3.87	43.83	T4			
		23095	3M	-4, -0.5	-3.65	43.17	T4			
			5M	-4, -0.5	-3.63	43.99	T4			
			10M	-5, -1	-4.21	42.59	T4			
	LTE B14	23330	5M	-4, -0.5	-3.68	43.03	T4			
		23330	10M	-2, -0.5	-2.48	42.21	T4			
	LTE B30	27710	5M	-4, -1	-3.80	42.33	T4			
	LIE DOU	27710	10M	-4, -1	-3.81	42.00	T4			
			1.4M	-4.5,9	4.16	44.04	T4			
	LTE B2		ЗM	-4.5,8.5	4.52	44.20	T4			
		18000	5M	-4.5,8.5	4.70	45.05	T4			
		18900	10M	-4.5,8.5	4.67	44.45	T4			
			15M	-5,7	5.08	44.21	T4			
			20M	-5,7	5.19	43.49	T4			
			1.4M	-4.5,9	4.52	45.36	T4			
			3M	-5, 9	4.42	45.93	T4			
	LTE B4	20175	5M	-4.5, 8	4.83	45.67	T4			
Perpendicular		20173	10M	-4.5, 7.5	5.01	44.68	T4			
			15M	-4.5, 7	4.95	44.79	T4			
			20M	-4.5, 8	4.86	45.23	T4			
			1.4M	-1.5,9.5	7.03	50.70	T4			
	LTE B5	20525	3M	-4.5,8.5	4.96	47.58	T4			
		20020	5M	-4.5,8.5	4.85	46.74	T4			
			10M	-4,9	4.83	46.39	T4			
			1.4M	-3.5, 8	5.86	47.26	T4			
	LTE B12	23095	3M	-4.5, 7.5	5.26	46.53	T4			
			5M	-3.5, 8	5.70	46.57	T4			
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		10M	-2.5, 8.5	6.28	45.89	T4
LTE B14	23330	5M	-4, 7.5	5.42	46.32	T4
	23330	10M	-3.5, 8.5	5.75	46.13	T4
	TE B30 27710 -	5M	-4.5, 7	4.99	45.17	T4
		10M	-4.5, 8	5.03	45.44	T4

Note:

1. Bluetooth and WiFi function is turn off and microphone is muted.

2. The worse case of each band for signal strength measurement scan plots are presented in Annex B.

3. The volume is adjusted to maximum level during T-Coil testing.

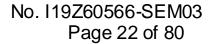
10.3 Total Measurement Conclusion

Probe Position	Frequency Band(MHz)	ABM1	Frequency Response	T Category
	GSM 850	Pass		T4
	GSM 1900	Pass		T4
	WCDM A850	Pass	-	T4
	WCDM A1900	Pass		T4
	WCDMA1700	Pass		T4
Transverse	LTE B2	Pass	/	T4
	LTE B4	Pass		T4
	LTE B5	Pass		T4
	LTE B12	Pass		T4
	LTE B14	Pass		T4
	LTE B30	Pass		T4
	GSM 850	Pass	Pass	T4
	GSM 1900	Pass	Pass	T4
	WCDM A850	Pass	Pass	T4
	WCDM A1900	Pass	Pass	T4
	WCDM A1700	Pass	Pass	T4
Perpendicular	LTE B2	Pass	Pass	T4
	LTE B4	Pass	Pass	T4
	LTE B5	Pass	Pass	T4
	LTE B12	Pass	Pass	T4
	LTE B14	Pass	Pass	T4
	LTE B30	Pass	Pass	T4



11 MEASUREMENT UNCERTAINTY

			Uncertainty					Std. Unc.	Std. Unc.
No.	Error source	Туре	Value a _i (%)	Prob. Dist.	Div.	ABM1 ci	ABM2 ci		ABM2 ^{<i>u</i>_i}
								(%)	(%)
1	System Repeatability	А	0.016	Ν	1	1	1	0.016	0.016
Prob	e Sensitivity		1					1	
2	Reference Level	В	3. 0	R	$\sqrt{3}$	1	1	3.0	3. 0
3	AMCC Geometry	В	0.4	R	$\sqrt{3}$	1	1	0.2	0.2
4	AMCC Current	В	0.6	R	$\sqrt{3}$	1	1	0.4	0.4
5	Probe Positioning during Calibration	В	0.1	R	$\sqrt{3}$	1	1	0.1	0.1
6	Noise Contribution	В	0.7	R	$\sqrt{3}$	0.014 3	1	0.0	0.4
7	Frequency Slope	В	5.9	R	$\sqrt{3}$	0.1	1	0. 3	3. 5
Prob	e System								
8	Repeatability / Drift	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6
9	Linearity / DynamicRange	В	0.6	Ν	1	1	1	0.4	0.4
10	Acoustic Noise	В	1.0	R	$\sqrt{3}$	0.1	1	0.1	0.6
11	Probe Angle	В	2.3	R	$\sqrt{3}$	1	1	1.4	1.4
12	Spectral Processing	В	0.9	R	$\sqrt{3}$	1	1	0.5	0.5
13	Integration Time	В	0.6	Ν	1	1	5	0.6	3.0
14	Field Distribution	В	0.2	R	$\sqrt{3}$	1	1	0.1	0.1
Test	Signal			•	•	•			
15	Ref.Signal Spectral Response	В	0.6	R	$\sqrt{3}$	0	1	0.0	0.4
Posit	ioning							·	<u>.</u>
16	Probe Positioning	В	1.9	R	$\sqrt{3}$	1	1	1.1	1.1
17	Phantom Thickness	В	0. 9	R	$\sqrt{3}$	1	1	0.5	0. 5





18	DUT Positioning	В	1.9	R	$\sqrt{3}$	1	1	1.1	1.1
Exter	rnal Contributions								
19	RF Interference	В	0.0	R	$\sqrt{3}$	1	0.3	0.0	0.0
20	Test Signal Variation	В	2.0	R	$\sqrt{3}$	1	1	1.2	1.2
Combined Std. Uncertainty (ABM Field) $u_c = \sqrt{\sum_{i=1}^{20} c_i^2 u_i^2}$						4.1	6. 1		
Expanded Std. Uncertainty		ι	$u_e = 2u_c$	Ν		<i>k</i> = 2		8. 2	12. 2

12 MAIN TEST INSTRUMENTS

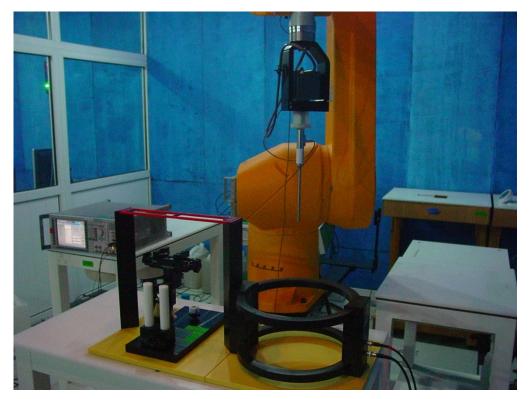
No.	Name	Туре	Serial Number	Calibration Date	Valid Period						
01	Audio Magnetic 1D Field Probe	AM1DV2	1064	July 17, 2018	NCR						
02	Audio Magnetic Calibration Coil	AMCC	1064	NCR	NCR						
03	Audio Measuring Instrument	AMMI	1044	NCR	NCR						
04	HAC Test Arch	N/A	1014	NCR	NCR						
05	DAE	DAE4	1555	August 20, 2018	One year						
06	Software	DASY5 V5.0 Build 119.9	N/A	NCR	NCR						
07	Software	SEMCAD V13.2 Build 87	N/A	NCR	NCR						
08	Universal Radio Communication Tester	CMW 500	166370	August 23, 2018	One year						

List of Main Instruments

END OF REPORT BODY



ANNEX A TEST LAYOUT



Picture A1: HAC T-Coil System Layout



ANNEX B TEST PLOTS

T-Coil GSM 850 Transverse Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3 Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

Signal(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = -0.76 dBA/m BWC Factor = 0.16 dB Location: 3.8, 13.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

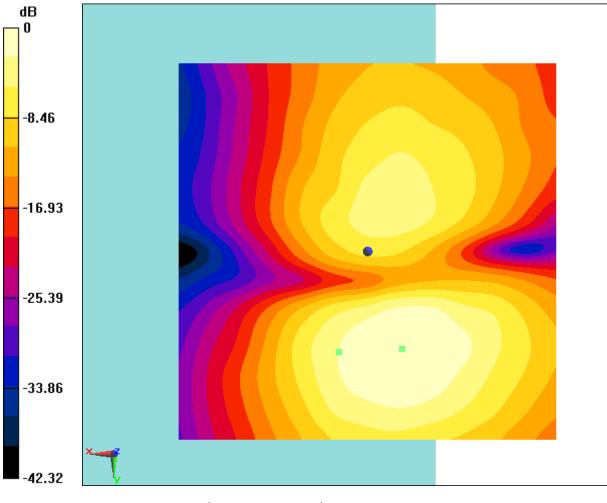
SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 38.24 dB ABM1 comp = -3.63 dBA/m



BWC Factor = 0.16 dB Location: -4.6, 12.9, 3.7 mm



0 dB = 0.9160 A/m = -0.76 dBA/m

Fig B.1 T-Coil GSM 850

T-Coil GSM 850 Perpendicular

Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3 Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated

Signal(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 6.85 dBA/m BWC Factor = 0.16 dB Location: 3.8, 3.7, 3.7 mm

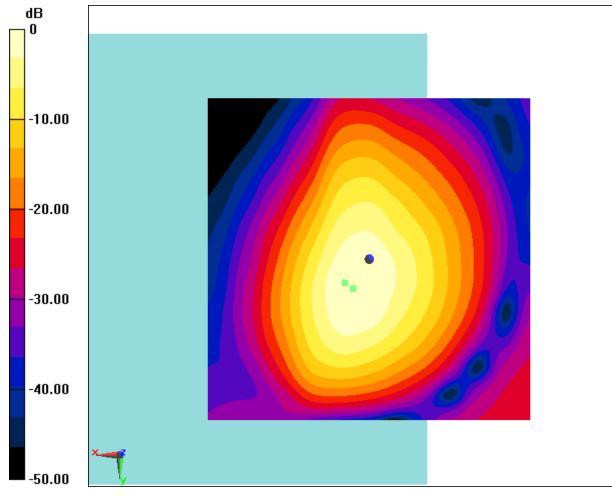
T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated

SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 42.23 dB ABM1 comp = 6.57 dBA/m BWC Factor = 0.16 dB Location: 2.5, 4.6, 3.7 mm





0 dB = 2.200 A/m = 6.85 dBA/m

Fig B.2 T-Coil GSM 850



T-Coil GSM 1900 Transverse Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: GSM 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3 Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

Signal (x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -0.28 dBA/m BWC Factor = 0.16 dB Location: 3.8, 12.9, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

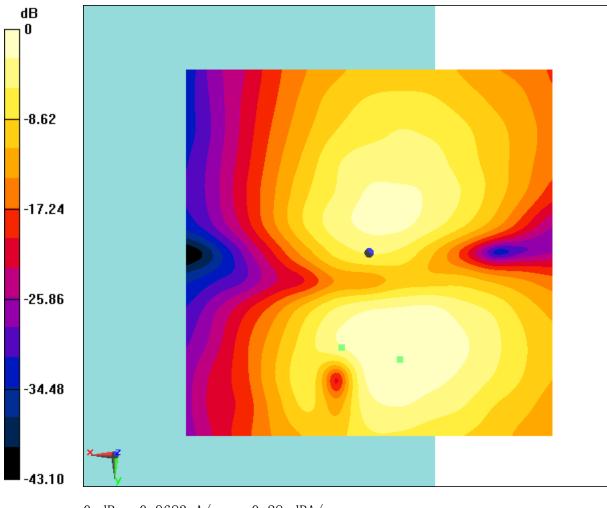
SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

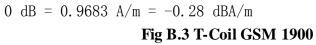
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 39.62 dB ABM1 comp = -2.97 dBA/m BWC Factor = 0.16 dB Location: -4.2, 14.6, 3.7 mm



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T-Coil GSM 1900 Perpendicular Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: GSM 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3 Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 FRV1/ABM Interpolated

Signal(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.12 dBA/m BWC Factor = 0.16 dB Location: 3.8, 2.5, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 FRV1/ABM Interpolated

SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 44.29 dBABM1 comp = 6.53 dBA/m



BWC Factor = 0.16 dB Location: 0.8, 3.7, 3.7 mm

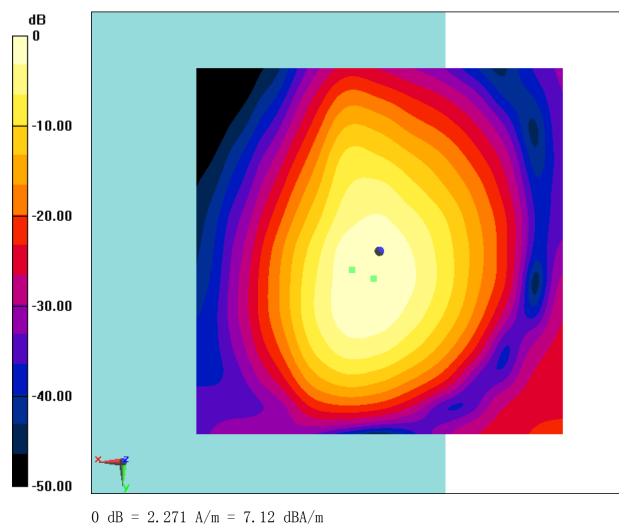


Fig B.4 T-Coil GSM 1900

T-Coil WCDMA 850 Transverse Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: WCDMA 850; Frequency: 836.4 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 2/ABM Interpolated

Signal (x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -0.06 dBA/m BWC Factor = 0.16 dB Location: 3.8, 12.9, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 2/ABM Interpolated

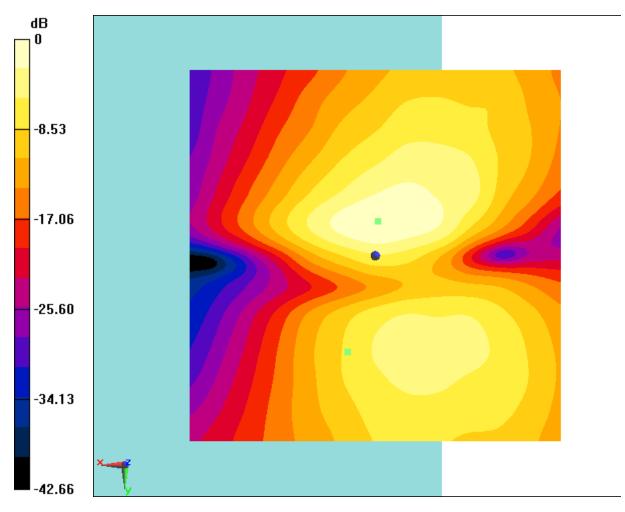
SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 42.48 dB ABM1 comp = -3.87 dBA/m BWC Factor = 0.16 dB Location: -0.4, -4.6, 3.7 mm



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 $0 \ dB = 0.9937 \ A/m = -0.06 \ dBA/m$

Fig B.5 T-Coil WCDMA 850



T-Coil WCDMA 850 Perpendicular Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: WCDMA 850; Frequency: 836.4 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated

Signal(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.75 dBA/m BWC Factor = 0.16 dB Location: 3.3, 3.7, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated

SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

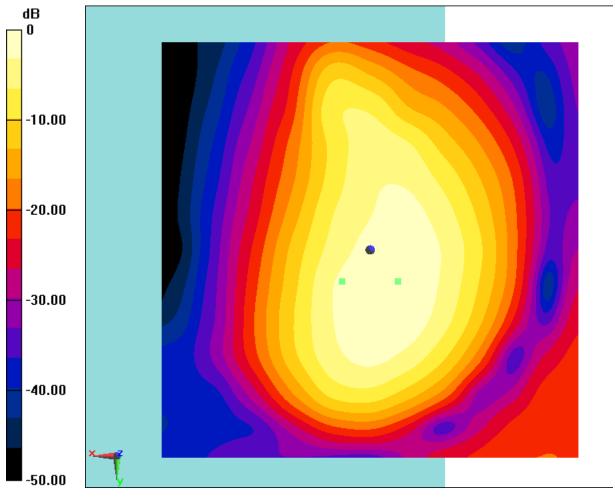
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 46.08 dBABM1 comp = 4.47 dBA/m



BWC Factor = 0.16 dB Location: -3.3, 3.7, 3.7 mm



0 dB = 2.439 A/m = 7.75 dBA/m

Fig B.6 T-Coil WCDMA 850



T-Coil WCDMA 1900 Transverse Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: WCDMA 1900; Frequency: 1880 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

Signal(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -0.55 dBA/m BWC Factor = 0.16 dB Location: 3.8, 12.9, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

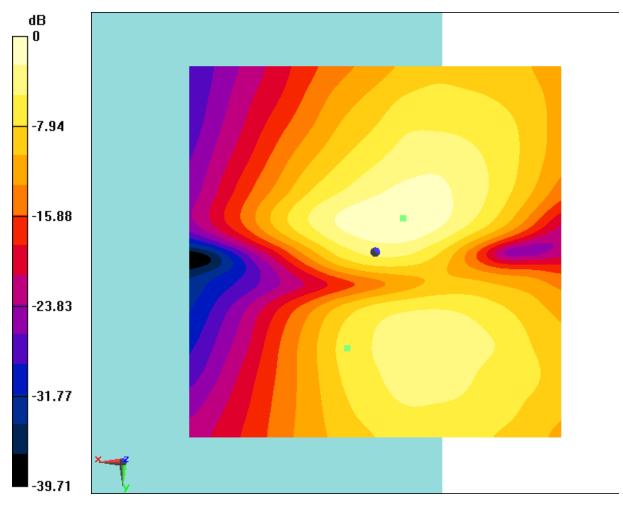
SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 40.91 dB ABM1 comp = -5.26 dBA/m BWC Factor = 0.16 dB Location: -3.7, -4.6, 3.7 mm



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0 dB = 0.9383 A/m = -0.55 dBA/m

Fig B.7 T-Coil WCDMA 1900



T-Coil WCDMA 1900 Perpendicular Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: WCDMA 1900; Frequency: 1880 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 7.95kbps/ABM Interpolated

Signal(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 6.66 dBA/m BWC Factor = 0.16 dB Location: 3.8, 2.5, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 7.95kbps/ABM Interpolated

SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

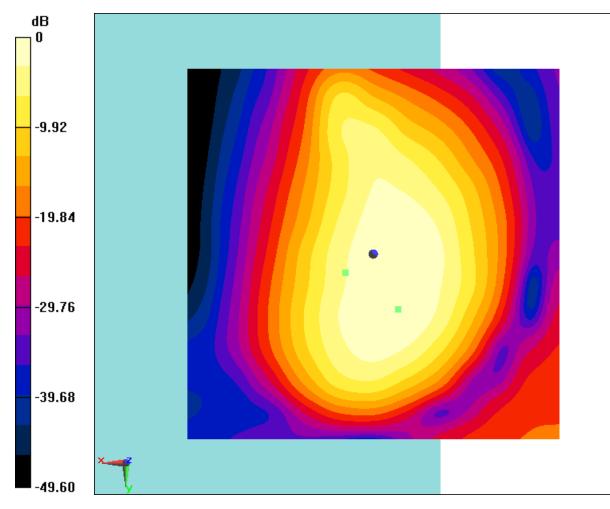
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 44.65 dB ABM1 comp = 1.70 dBA/m BWC Factor = 0.16 dB Location: -3.3, 7.5, 3.7 mm



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0 dB = 2.153 A/m = 6.66 dBA/m

Fig B.8 T-Coil WCDMA 1900



T-Coil WCDMA 1700 Transverse Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: WCDMA 1700; Frequency: 1732.4 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

Signal (x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -0.64 dBA/m BWC Factor = 0.16 dB Location: 2.5, 13.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

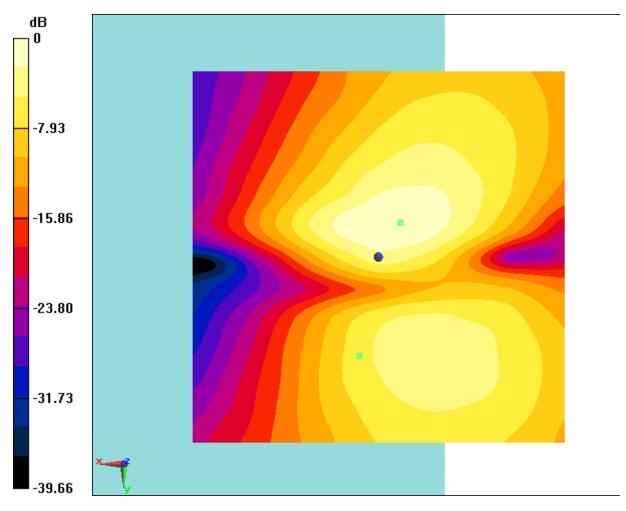
SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 40.95 dB ABM1 comp = -4.94 dBA/m BWC Factor = 0.16 dB Location: -2.9, -4.6, 3.7 mm



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0 dB = 0.9292 A/m = -0.64 dBA/m

Fig B.9 T-Coil WCDMA 1700



T-Coil WCDMA 1700 Perpendicular Date: 2019-4-29 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: WCDMA 1700; Frequency: 1732.4 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated

Signal (x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 6.74 dBA/m BWC Factor = 0.16 dB Location: 2.9, 3.3, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated

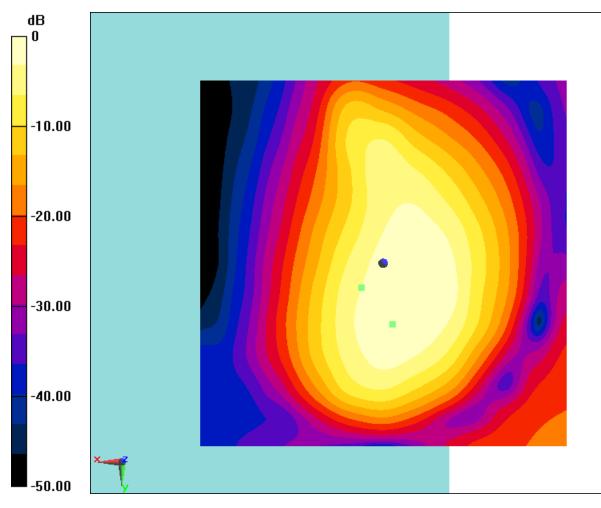
SNR(x, y, z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 37.15 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 44.93 dB ABM1 comp = 4.02 dBA/m BWC Factor = 0.16 dB Location: -1.2, 8.3, 3.7 mm





0 dB = 2.173 A/m = 6.74 dBA/m

Fig B.10 T-Coil WCDMA 1700



T-Coil LTE B2 20M Transverse Date: 2019-5-1 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B2; Frequency: 1880 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B2 20M 16QAM 1RB50 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 1.48 dBA/m BWC Factor = 0.16 dB Location: 1, 16, 3.7 mm

T-Coil/LTE B2 20M 16QAM 1RB50 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

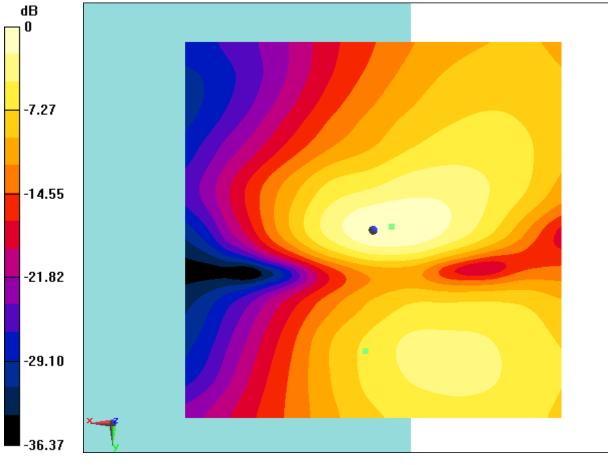
dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 42.62 dB ABM1 comp = -2.24 dBA/m

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BWC Factor = 0.16 dB Location: -2.5, -0.5, 3.7 mm



0 dB = 1.185 A/m = 1.48 dBA/m

Fig B.11 T-Coil LTE B2



T-Coil LTE B2 20M Perpendicular Date: 2019-5-1 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B2; Frequency: 1880 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B2 20M 16QAM 1RB50 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 8.31 dBA/m BWC Factor = 0.16 dB Location: 1.5, 6.5, 3.7 mm

T-Coil/LTE B2 20M 16QAM 1RB50 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

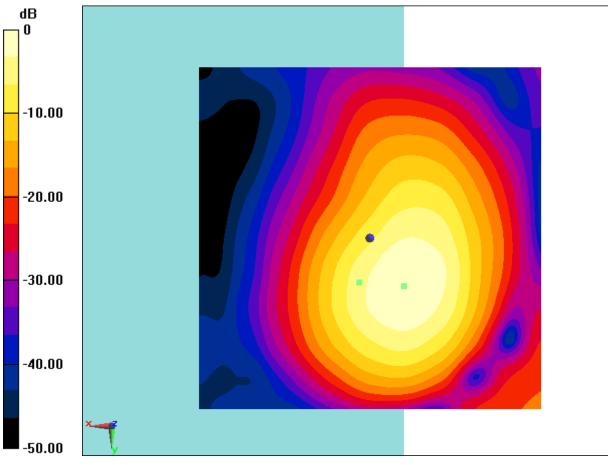
Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 43.49 dB



ABM1 comp = 5.19 dBA/m BWC Factor = 0.16 dB Location: -5, 7, 3.7 mm



0 dB = 2.603 A/m = 8.31 dBA/m

Fig B.12 T-Coil LTE B2



T-Coil LTE B4 20M Transverse Date: 2019-5-2 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B4; Frequency: 1732.5 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B4 20M 16QAM 1RB50 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 0.84 dBA/m BWC Factor = 0.16 dB

Location: 2, 16, 3.7 mm

T-Coil/LTE B4 20M 16QAM 1RB50 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

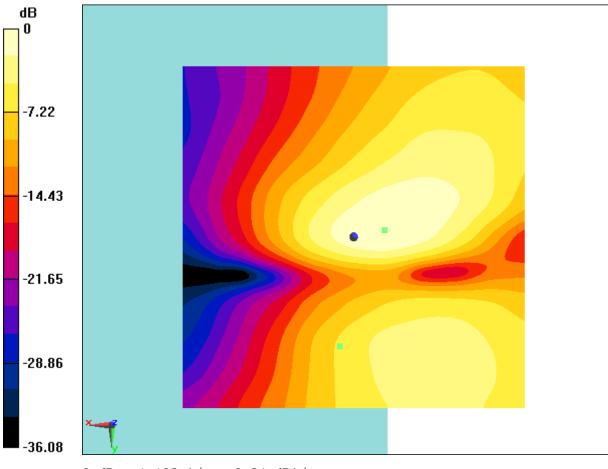
dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 41.04 dBABM1 comp = -3.99 dBA/m



BWC Factor = 0.16 dBLocation: -4.5, -1, 3.7 mm



0 dB = 1.102 A/m = 0.84 dBA/m

Fig B.13 T-Coil LTE B4



T-Coil LTE B4 10M Perpendicular Date: 2019-5-2 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B4; Frequency: 1732.5 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B4 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.51 dBA/m BWC Factor = 0.16 dB Location: 1, 7, 3.7 mm

T-Coil/LTE B4 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

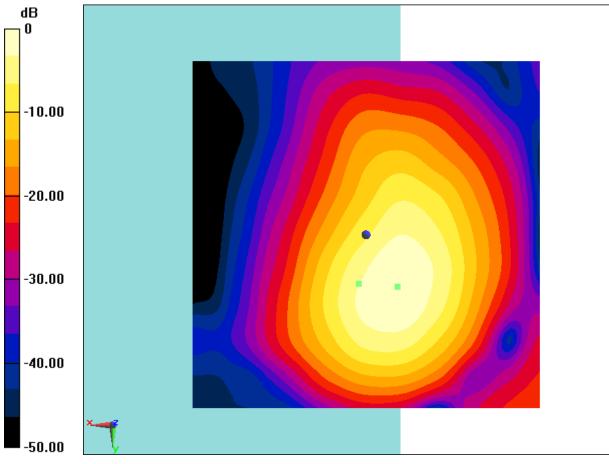
Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 44.68 dB



ABM1 comp = 5.01 dBA/mBWC Factor = 0.16 dBLocation: -4.5, 7.5, 3.7 mm



0 dB = 2.373 A/m = 7.51 dBA/m

Fig B.14 T-Coil LTE B4



T-Coil LTE B5 10M Transverse Date: 2019-5-2 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B5; Frequency: 836.5 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B5 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 0.92 dBA/m BWC Factor = 0.16 dB Location: 1, 16, 3.7 mm

T-Coil/LTE B5 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

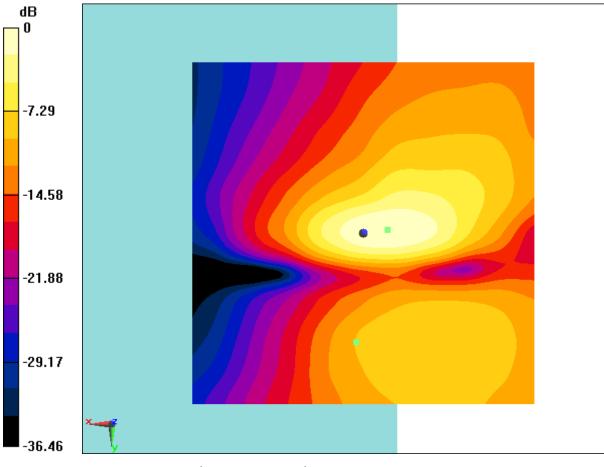
dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 45.39 dBABM1 comp = -3.66 dBA/m



BWC Factor = 0.16 dB Location: -3.5, -0.5, 3.7 mm



0 dB = 1.112 A/m = 0.92 dBA/m

Fig B.15 T-Coil LTE B5



T-Coil LTE B5 10M Perpendicular Date: 2019-5-2 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B5; Frequency: 836.5 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B5 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.42 dBA/m BWC Factor = 0.16 dB Location: 0.5, 7, 3.7 mm

T-Coil/LTE B5 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

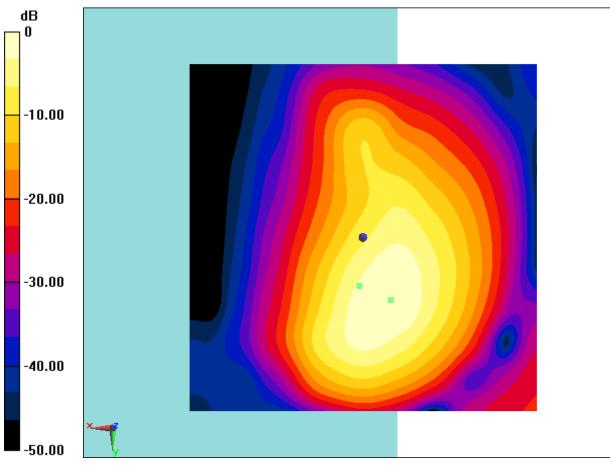
Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 46.39 dB



ABM1 comp = 4.83 dBA/mBWC Factor = 0.16 dBLocation: -4, 9, 3.7 mm



0 dB = 2.350 A/m = 7.42 dBA/m

Fig B.16 T-Coil LTE B5

T-Coil LTE B12 10M Transverse Date: 2019-5-2 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B12; Frequency: 707.5 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B12 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 0.86 dBA/m BWC Factor = 0.16 dB Location: 1, 16, 3.7 mm

T-Coil/LTE B12 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

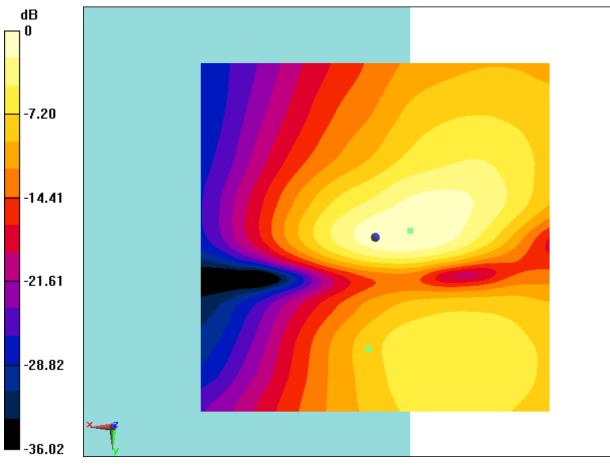
dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 42.59 dBABM1 comp = -4.21 dBA/m



BWC Factor = 0.16 dBLocation: -5, -1, 3.7 mm



0 dB = 1.105 A/m = 0.86 dBA/m

Fig B.17 T-Coil LTE B12



T-Coil LTE B12 10M Perpendicular Date: 2019-5-2 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B12; Frequency: 707.5 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B12 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.64 dBA/m BWC Factor = 0.16 dB Location: 0.5, 6.5, 3.7 mm

T-Coil/LTE B12 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

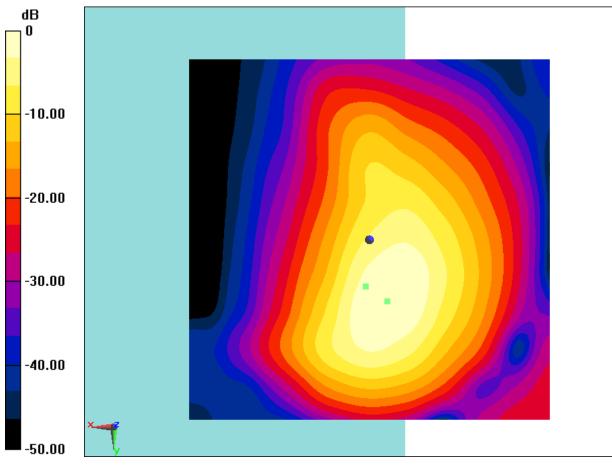
Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 45.89 dB



ABM1 comp = 6.28 dBA/m BWC Factor = 0.16 dB Location: -2.5, 8.5, 3.7 mm



0 dB = 2.411 A/m = 7.64 dBA/m

Fig B.18 T-Coil LTE B12

T-Coil LTE B14 10M Transverse Date: 2019-5-3 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B14; Frequency: 793 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B14 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 1.09 dBA/m BWC Factor = 0.16 dB Location: 1, 16, 3.7 mm

T-Coil/LTE B14 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

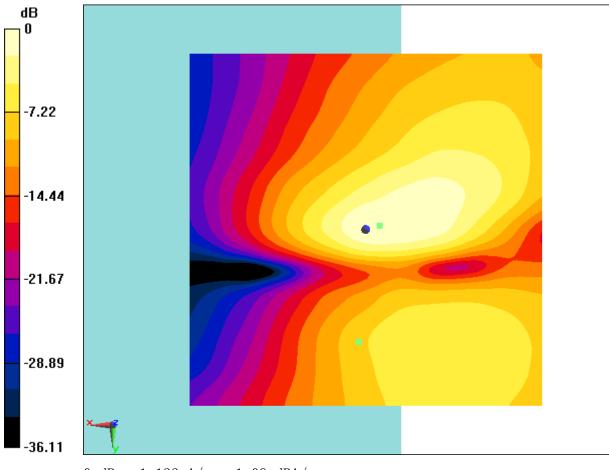
dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 42.21 dBABM1 comp = -2.48 dBA/m



BWC Factor = 0.16 dBLocation: -2, -0.5, 3.7 mm



0 dB = 1.133 A/m = 1.09 dBA/m

Fig B.19 T-Coil LTE B14



T-Coil LTE B14 10M Perpendicular Date: 2019-5-3 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B14; Frequency: 793 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B14 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.70 dBA/m BWC Factor = 0.16 dB Location: 0.5, 6.5, 3.7 mm

T-Coil/LTE B14 10M 16QAM 1RB25 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

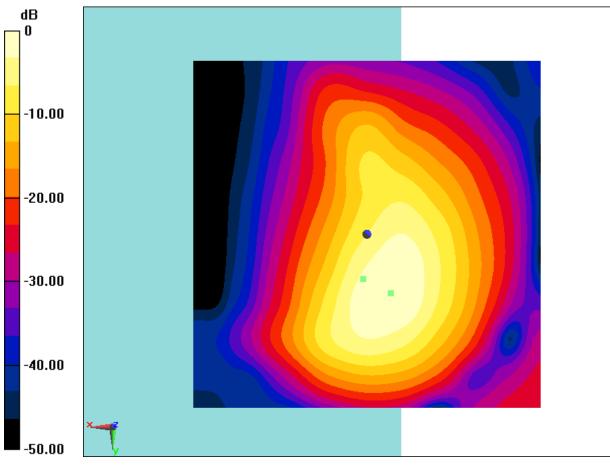
Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 46.13 dB



ABM1 comp = 5.75 dBA/m BWC Factor = 0.16 dB Location: -3.5, 8.5, 3.7 mm



0 dB = 2.426 A/m = 7.70 dBA/m

Fig B.20 T-Coil LTE B14

T-Coil LTE B30 10M Transverse Date: 2019-5-3 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B30; Frequency: 2310 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B30 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 0.90 dBA/m BWC Factor = 0.16 dB Location: 1.5, 16, 3.7 mm

T-Coil/LTE B30 10M 16QAM 1RB25 NB 4.75/y (transversal) 4.2mm 50 x 50/ABM

Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

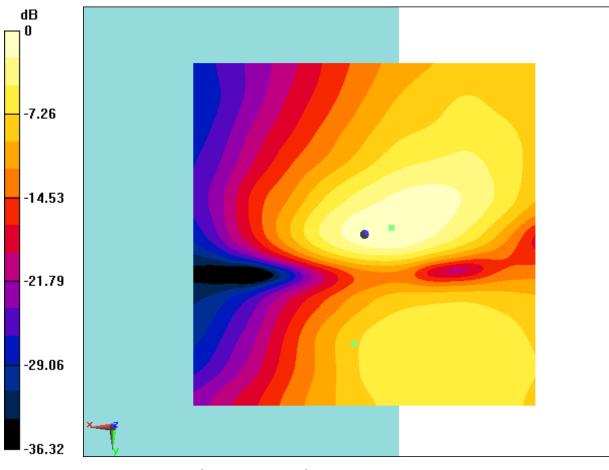
dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 42.00 dBABM1 comp = -3.81 dBA/m



BWC Factor = 0.16 dBLocation: -4, -1, 3.7 mm



0 dB = 1.110 A/m = 0.90 dBA/m

Fig B.21 T-Coil LTE B30



T-Coil LTE B30 5M Perpendicular Date: 2019-5-3 Electronics: DAE4 Sn1555 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Ambient Temperature:22.5°C Communication System: LTE B30; Frequency: 2310 MHz; Duty Cycle: 1:1 Probe: AM1DV2 - 1064;

T-Coil/LTE B30 5M 16QAM 1RB12 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

Interpolated Signal(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1 = 7.65 dBA/m BWC Factor = 0.16 dB Location: 1, 6.5, 3.7 mm

T-Coil/LTE B30 5M 16QAM 1RB12 NB 4.75/z (axial) 4.2mm 50 x 50/ABM

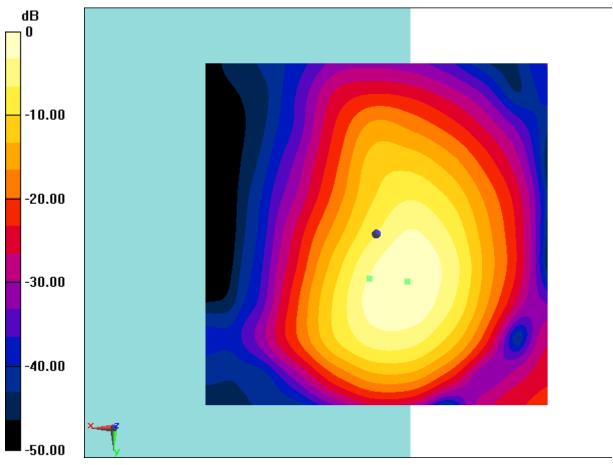
Interpolated SNR(x, y, z) (101x101x1): Interpolated grid: dx=1.000 mm,

dy=1.000 mm Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav Output Gain: 100 Measure Window Start: 300ms Measure Window Length: 1000ms BWC applied: 0.16 dB Device Reference Point: 0, 0, -6.3 mm

Cursor: ABM1/ABM2 = 45.17 dB



ABM1 comp = 4.99 dBA/mBWC Factor = 0.16 dBLocation: -4.5, 7, 3.7 mm

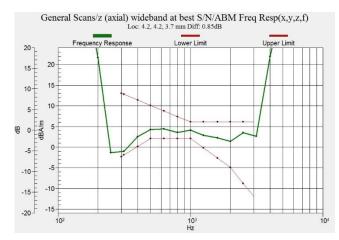


0 dB = 2.412 A/m = 7.65 dBA/m

Fig B.22 T-Coil LTE B30



ANNEX C FREQUENCY REPONSE CURVES





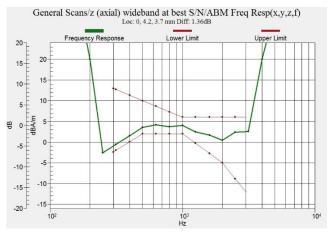


Figure C.2 Frequency Response of GSM 1900

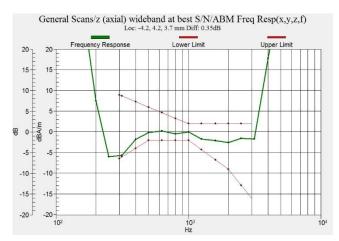
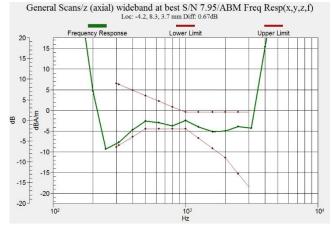


Figure C.3 Frequency Response of WCDMA 850

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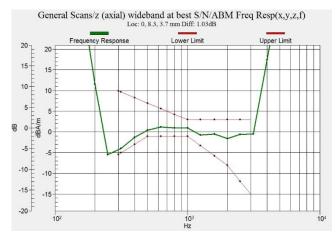


Figure C.5 Frequency Response of WCDMA 1700

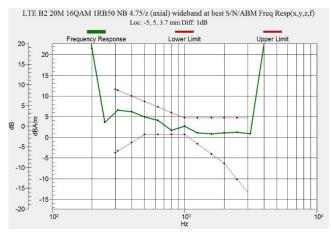
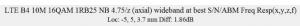
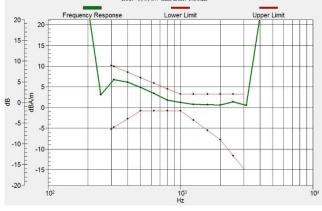


Figure C.6 Frequency Response of LTE B2

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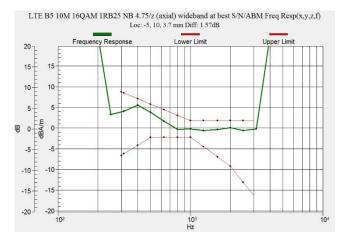


Figure C.8 Frequency Response of LTE B5

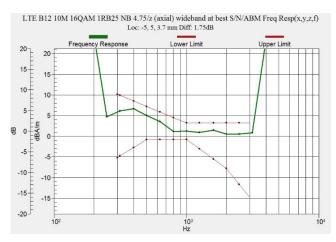
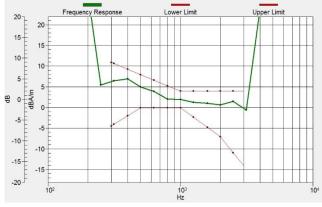


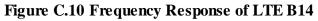
Figure C.9 Frequency Response of LTE B12

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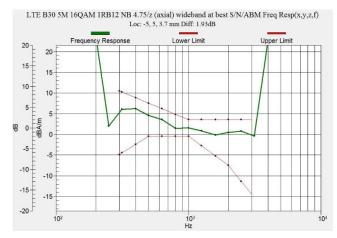


Figure C.11 Frequency Response of LTE B30



ANNEX D PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

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Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

			Certificate No: AM1DV2-1064_Jul18	
CALIBRATION CI	ERTIFICA	TE		
Object	AM1DV2 - SN:			
Calibration procedure(s)	QA CAL-24.v4 Calibration pro audio range	bes and TMFS in the		
Calibration date:	July 17, 2018			
The measurements and the uncerta	ainties with confidenc ed in the closed labora	national standards, which realize the physical unit: the probability are given on the following pages and atory facility: environment temperature (22 ± 3)°C n)	are part of the certificate.	
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	
Keithley Multimeter Type 2001	SN: 0810278	31-Aug-17 (No. 21092)	Aug-18	
Reference Probe AM1DV2	SN: 1008	03-Jan-18 (No. AM1DV2-1008_Jan18)	Jan-19	
DAE4	SN: 781	17-Jan-18 (No. DAE4-781_Jan18)	Jan-19	
Secondary Standards	ID #	Check Date (in house)	Scheduled Check	
AMCC	SN: 1050	01-Oct-13 (in house check Oct-17)	Oct-19	
AMMI Audio Measuring Instrument	SN: 1062	26-Sep-12 (in house check Oct-17)	Oct-19	
0				
	Namo	Eurotion	Signatura	
	Name Leif Klysner	Function Laboratory Technician	Signature	
Calibrated by: Approved by:	a select substant of the Article Articles and the		Signature Seif Magur	

Certificate No: AM1DV2-1064_Jul18

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[References

[1] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

- [2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [3] DASY5 manual, Chapter: Hearing Aid Compatibility (HAC) T-Coil Extension

Description of the AM1D probe

The AM1D Audio Magnetic Field Probe is a fully shielded magnetic field probe for the frequency range from 100 Hz to 20 kHz. The pickup coil is compliant with the dimensional requirements of [1+2]. The probe includes a symmetric low noise amplifier for the signal available at the shielded 3 pin connector at the side. Power is supplied via the same connector (phantom power supply) and monitored via the LED near the connector. The 7 pin connector at the end of the probe does not carry any signals, but determines the angle of the sensor when mounted on the DAE. The probe supports mechanical detection of the surface.

The single sensor in the probe is arranged in a tilt angle allowing measurement of 3 orthogonal field components when rotating the probe by 120° around its axis. It is aligned with the perpendicular component of the field, if the probe axis is tilted nominally 35.3° above the measurement plane, using the connector rotation and sensor angle stated below.

The probe is fully RF shielded when operated with the matching signal cable (shielded) and allows measurement of audio magnetic fields in the close vicinity of RF emitting wireless devices according to [1+2] without additional shielding.

Handling of the item

The probe is manufactured from stainless steel. In order to maintain the performance and calibration of the probe, it must not be opened. The probe is designed for operation in air and shall not be exposed to humidity or liquids. For proper operation of the surface detection and emergency stop functions in a DASY system, the probe must be operated with the special probe cup provided (larger diameter).

Methods Applied and Interpretation of Parameters

- Coordinate System: The AM1D probe is mounted in the DASY system for operation with a HAC Test Arch phantom with AMCC Helmholtz calibration coil according to [3], with the tip pointing to "southwest" orientation.
- Functional Test: The functional test preceding calibration includes test of Noise level
 RF immunity (1kHz AM modulated signal). The shield of the probe cable must be well connected.
 Frequency response verification from 100 Hz to 10 kHz.
- Connector Rotation: The connector at the end of the probe does not carry any signals and is used for fixation to the DAE only. The probe is operated in the center of the AMCC Helmholtz coil using a 1 kHz magnetic field signal. Its angle is determined from the two minima at nominally +120° and – 120° rotation, so the sensor in the tip of the probe is aligned to the vertical plane in z-direction, corresponding to the field maximum in the AMCC Helmholtz calibration coil.
- Sensor Angle: The sensor tilting in the vertical plane from the ideal vertical direction is determined from the two minima at nominally +120° and -120°. DASY system uses this angle to align the sensor for radial measurements to the x and y axis in the horizontal plane.
- Sensitivity: With the probe sensor aligned to the z-field in the AMCC, the output of the probe is compared to the magnetic field in the AMCC at 1 kHz. The field in the AMCC Helmholtz coil is given by the geometry and the current through the coil, which is monitored on the precision shunt resistor of the coil.

Certificate No: AM1DV2-1064_Jul18



AM1D probe identification and configuration data

Item	AM1DV2 Audio Magnetic 1D Field Probe
Type No	SP AM1 001 AF
Serial No	1064

Overall length	296 mm	1775
Tip diameter	6.0 mm (at the tip)	
Sensor offset	3.0 mm (centre of sensor from tip)	
Internal Amplifier	40 dB	- 22

Manufacturer / Origin Schmid & Partner Engineering AG, Zurich, Switzerland

Calibration data

Connector rotation angle	(in DASY system)	101.8 °	+/- 3.6 ° (k=2)
Sensor angle	(in DASY system)	0.52 °	+/- 0.5 ° (k=2)
Sensitivity at 1 kHz	(in DASY system)	0.0657 V / (A/m)	+/- 2.2 % (k=2)

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: AM1DV2-1064_Jul18

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ANNEX E DAE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service

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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

	len)	Certificate No	Certificate No: DAE4-1555_Aug18			
CALIBRATION C	ERTIFICATE					
Object	DAE4 - SD 000 D	DAE4 - SD 000 D04 BN - SN: 1555				
Calibration procedure(s)	QA CAL-06.v29 Calibration proced	QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE)				
Calibration date:	August 20, 2018					
The measurements and the unce	rtainties with confidence pro	nal standards, which realize the physical un obability are given on the following pages an r facility: environment temperature (22 ± 3)°(d are part of the certificate.			
Calibration Equipment used (M&T		·······				
	,					
Primany Standarde		Cal Data (Cartificate No.)	Schodulad Calibration			
Primary Standards Keithley Multimeter Type 2001	ID # SN: 0810278	Cal Date (Certificate No.) 31-Aug-17 (No:21092)	Scheduled Calibration			
	ID # SN: 0810278	Cal Date (Certificate No.) 31-Aug-17 (No:21092)	Scheduled Calibration Aug-18			
Keithley Multimeter Type 2001 Secondary Standards	SN: 0810278	31-Aug-17 (No:21092) Check Date (in house)	Aug-18 Scheduled Check			
Keithley Multimeter Type 2001	SN: 0810278 ID # SE UWS 053 AA 1001	31-Aug-17 (No:21092)	Aug-18			
Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit Calibrator Box V2.1	SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	31-Aug-17 (No:21092) Check Date (in house) 04-Jan-18 (in house check) 04-Jan-18 (in house check)	Aug-18 Scheduled Check In house check: Jan-19 In house check: Jan-19 Signature			
Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit	SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	31-Aug-17 (No:21092) Check Date (in house) 04-Jan-18 (in house check) 04-Jan-18 (in house check)	Aug-18 Scheduled Check In house check: Jan-19 In house check: Jan-19 Signature			
Keithley Multimeter Type 2001 Secondary Standards Auto DAE Calibration Unit Calibrator Box V2.1	SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	31-Aug-17 (No:21092) Check Date (in house) 04-Jan-18 (in house check) 04-Jan-18 (in house check)	Aug-18 Scheduled Check In house check: Jan-19 In house check: Jan-19			

Certificate No: DAE4-1555_Aug18

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Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: SCS 0108 The Swiss Accreditation Service is one of the signatories to the EA

Glossary

DAE Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

Multilateral Agreement for the recognition of calibration certificates

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a . result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement. Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resol	ution nominal			
High Range:	1LSB =	6.1μV ,	full range =	-100+300 mV
Low Range:	1LSB =	61nV ,	full range =	-1+3mV
DASY measurement p	arameters: Aut	o Zero Time: 3	sec; Measuring	time: 3 sec

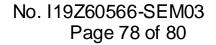
Calibration Factors	X	Y	Z
High Range	404.540 ± 0.02% (k=2)	404.077 ± 0.02% (k=2)	405.023 ± 0.02% (k=2)
Low Range	3.92909 ± 1.50% (k=2)	3.94558 ± 1.50% (k=2)	3.97891 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	104.0 ° ± 1 °

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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (µV)	Difference (µV)	Error (%)
Channel X	+ Input	199994.32	-1.11	-0.00
Channel X	+ Input	20004.21	2.27	0.01
Channel X	- Input	-19994.21	6.72	-0.03
Channel Y	+ Input	199991.01	-4.74	-0.00
Channel Y	+ Input	19999.15	-2.66	-0.01
Channel Y	- Input	-19999.37	1.70	-0.01
Channel Z	+ Input	199997.50	1.46	0.00
Channel Z	+ Input	19998.75	-3.06	-0.02
Channel Z	- Input	-20003.08	-1.96	0.01

Low Range		Reading (µV)	Difference (µV)	Error (%)
Channel X + I	nput	2001.23	-0.12	-0.01
Channel X + I	nput	201.73	0.03	0.02
Channel X - Ir	nput	-197.79	0.32	-0.16
Channel Y + I	nput	2001.22	0.00	0.00
Channel Y + I	nput	201.15	-0.62	-0.31
Channel Y - II	nput	-198.47	-0.28	0.14
Channel Z + I	nput	2001.41	0.23	0.01
Channel Z + I	nput	200.99	-0.67	-0.33
Channel Z - I	nput	-199.42	-1.11	0.56

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (µV)
Channel X	200	-10.02	-11.33
5	- 200	12.53	10.76
Channel Y	200	10.66	10.40
	- 200	-12.33	-12.29
Channel Z	200	-2.18	-2.52
	- 200	0.20	-0.09

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (µV)
Channel X	200	-	-0.85	-2.68
Channel Y	200	8.65	-	0.04
Channel Z	200	6.10	6.93	

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15635	14959
Channel Y	15850	16040
Channel Z	16635	16604

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec input $10M\Omega$

	Average (µV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.40	-0.72	1.60	0.48
Channel Y	0.06	-0.99	1.84	0.46
Channel Z	-0.76	-2.17	0.18	0.48

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

AT 1. 1977	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	0.01	-8	-9

Certificate No: DAE4-1555_Aug18



The photos of HAC test are presented in the additional document:

Appendix to test report no. I19Z60566-SEM02/03

The photos of HAC test